

# MegaMOS™ FET

IXTH / IXTM 10N100  
IXTH / IXTM 12N100

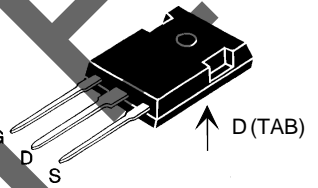
| $V_{DSS}$ | $I_{D25}$ | $R_{DS(on)}$  |
|-----------|-----------|---------------|
| 1000 V    | 10 A      | 1.20 $\Omega$ |
| 1000 V    | 12 A      | 1.05 $\Omega$ |

## N-Channel Enhancement Mode

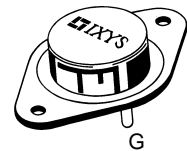


| Symbol        | Test Conditions   | Maximum Ratings             |                  |
|---------------|---|-----------------------------|------------------|
| $V_{DSS}$     | $T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$                                 | 1000                        | V                |
| $V_{DGR}$     | $T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$ ; $R_{GS} = 1\text{ M}\Omega$   | 1000                        | V                |
| $V_{GS}$      | Continuous  | $\pm 20$                    | V                |
| $V_{GSM}$     | Transient   | $\pm 30$                    | V                |
| $I_{D25}$     | $T_C = 25^\circ\text{C}$  | 10N100                      | 10 A             |
|               |   | 12N100                      | 12 A             |
| $I_{DM}$      | $T_C = 25^\circ\text{C}$ , pulse width limited by $T_{JM}$                      | 10N100                      | 40 A             |
|               |   | 12N100                      | 48 A             |
| $P_D$         | $T_C = 25^\circ\text{C}$  | 300                         | W                |
| $T_J$         |   | -55 ... +150                | $^\circ\text{C}$ |
| $T_{JM}$      |   | 150                         | $^\circ\text{C}$ |
| $T_{stg}$     |   | -55 ... +150                | $^\circ\text{C}$ |
| $M_d$         | Mounting torque   | 1.13/10                     | Nm/lb.in.        |
| <b>Weight</b> |   | TO-204 = 18 g, TO-247 = 6 g |                  |
|               | Maximum lead temperature for soldering<br>1.6 mm (0.062 in.) from case for 10 s | 300                         | $^\circ\text{C}$ |

TO-247 AD (IXTH)



TO-204 AA (IXTM)



G = Gate, D = Drain,  
S = Source, TAB = Drain

### Features

- International standard packages
- Low  $R_{DS(on)}$  HDMOS™ process
- Rugged polysilicon gate cell structure
- Low package inductance (< 5 nH)
  - easy to drive and to protect
- Fast switching times

### Applications

- Switch-mode and resonant-mode power supplies
- Motor controls
- Uninterruptible Power Supplies (UPS)
- DC choppers

### Advantages

- Easy to mount with 1 screw (TO-247) (isolated mounting screw hole)
- Space savings
- High power density

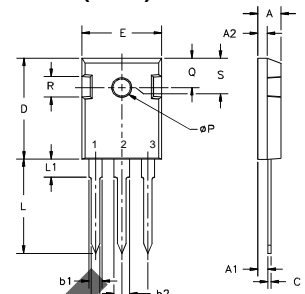
| Symbol       | Test Conditions   | Characteristic Values<br>( $T_J = 25^\circ\text{C}$ , unless otherwise specified) |      |                     |
|--------------|---|---|------|---------------------|
|              |   | min.  | typ. | max.                |
| $V_{DSS}$    | $V_{GS} = 0\text{ V}$ , $I_D = 3\text{ mA}$   | 1000  |      | V                   |
| $V_{GS(th)}$ | $V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$  | 2   |      | 4.5 V               |
| $I_{GSS}$    | $V_{GS} = \pm 20\text{ V}_{DC}$ , $V_{DS} = 0$  |   |      | $\pm 100\text{ nA}$ |
| $I_{DSS}$    | $V_{DS} = 0.8 \cdot V_{DSS}$<br>$V_{GS} = 0\text{ V}$   | $T_J = 25^\circ\text{C}$  |      | 250 $\mu\text{A}$   |
|              |   | $T_J = 125^\circ\text{C}$   |      | 1 mA                |
| $R_{DS(on)}$ | $V_{GS} = 10\text{ V}$ , $I_D = 0.5 I_{D25}$<br>Pulse test, $t \leq 300\text{ }\mu\text{s}$ , duty cycle $d \leq 2\%$ | 10N100  |      | 1.20 $\Omega$       |
|              |   | 12N100  |      | 1.05 $\Omega$       |

| Symbol       | Test Conditions   | Characteristic Values<br>( $T_J = 25^\circ\text{C}$ , unless otherwise specified) |      |      |    |
|--------------|---|---|------|------|----|
|              |   | min.  | typ. | max. |    |
| $g_{fs}$     | $V_{DS} = 10\text{ V}; I_D = 0.5 \cdot I_{D25}$ , pulse test  | 6   | 12   | S    |    |
| $C_{iss}$    | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$   |   | 4000 | pF   |    |
| $C_{oss}$    |   |   | 310  | pF   |    |
| $C_{rss}$    |   |   | 70   | pF   |    |
| $t_{d(on)}$  | $V_{GS} = 10\text{ V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = 0.5 I_{D25}$<br>$R_G = 2\ \Omega$ , (External) |   | 21   | 50   | ns |
| $t_r$        |   |   | 33   | 50   | ns |
| $t_{d(off)}$ |   |   | 62   | 100  | ns |
| $t_f$        |   |   | 32   | 50   | ns |
| $Q_{g(on)}$  | $V_{GS} = 10\text{ V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = 0.5 I_{D25}$                                   |   | 150  | 170  | nC |
| $Q_{gs}$     |   |   | 30   | 45   | nC |
| $Q_{gd}$     |   |   | 55   | 80   | nC |
| $R_{thJC}$   |   |   | 0.42 | K/W  |    |
| $R_{thCK}$   |   | 0.25  |      | K/W  |    |

### Source-Drain Diode

| Symbol   | Test Conditions   | Characteristic Values<br>( $T_J = 25^\circ\text{C}$ , unless otherwise specified) |      |          |        |
|----------|---|---|------|----------|--------|
|          |   | min.  | typ. | max.     |        |
| $I_S$    | $V_{GS} = 0\text{ V}$   | 10N100<br>12N100  |      | 10<br>12 | A<br>A |
| $I_{SM}$ | Repetitive;<br>pulse width limited by $T_{JM}$  | 10N100<br>12N100  |      | 40<br>48 | A<br>A |
| $V_{SD}$ | $I_F = I_S, V_{GS} = 0\text{ V}$ ,<br>Pulse test, $t \leq 300\ \mu\text{s}$ , duty cycle $d \leq 2\%$ |   |      | 1.5      | V      |
| $t_{rr}$ | $I_F = I_S, -di/dt = 100\text{ A}/\mu\text{s}, V_R = 100\text{ V}$                                    |   | 1000 |          | ns     |

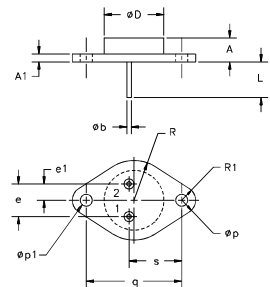
### TO-247 AD (IXTH) Outline



Terminals: 1 - Gate 2 - Drain  
3 - Source Tab - Drain

| Dim.           | Millimeter |       | Inches |       |
|----------------|------------|-------|--------|-------|
|                | Min.       | Max.  | Min.   | Max.  |
| A              | 4.7        | 5.3   | .185   | .209  |
| A <sub>1</sub> | 2.2        | 2.54  | .087   | .102  |
| A <sub>2</sub> | 2.2        | 2.6   | .059   | .098  |
| b              | 1.0        | 1.4   | .040   | .055  |
| b <sub>1</sub> | 1.65       | 2.13  | .065   | .084  |
| b <sub>2</sub> | 2.87       | 3.12  | .113   | .123  |
| C              | .4         | .8    | .016   | .031  |
| D              | 20.80      | 21.46 | .819   | .845  |
| E              | 15.75      | 16.26 | .610   | .640  |
| e              | 5.20       | 5.72  | 0.205  | 0.225 |
| L              | 19.81      | 20.32 | .780   | .800  |
| L1             |            | 4.50  |        | .177  |
| ∅P             | 3.55       | 3.65  | .140   | .144  |
| Q              | 5.89       | 6.40  | 0.232  | 0.252 |
| R              | 4.32       | 5.49  | .170   | .216  |
| S              | 6.15       | BSC   | 242    | BSC   |

### TO-204AA (IXTM) Outline



Pins 1 - Gate 2 - Source  
Case - Drain

| Dim.            | Millimeter |       | Inches |      |
|-----------------|------------|-------|--------|------|
|                 | Min.       | Max.  | Min.   | Max. |
| A               | 6.4        | 11.4  | .250   | .450 |
| A <sub>1</sub>  |            | 3.42  |        | .135 |
| ∅b              | .97        | 1.09  | .038   | .043 |
| ∅D              |            | 22.22 |        | .875 |
| e               | 10.67      | 11.17 | .420   | .440 |
| e <sub>1</sub>  | 5.21       | 5.71  | .205   | .225 |
| L               | 7.93       |       | .312   |      |
| ∅p              | 3.84       | 4.19  | .151   | .165 |
| ∅p <sub>1</sub> | 3.84       | 4.19  | .151   | .165 |
| q               | 30.15      | BSC   | 1.187  | BSC  |
| R               |            | 13.33 |        | .525 |
| R <sub>1</sub>  |            | 4.77  |        | .188 |
| s               | 16.64      | 17.14 | .655   | .675 |

Fig. 1 Output Characteristics

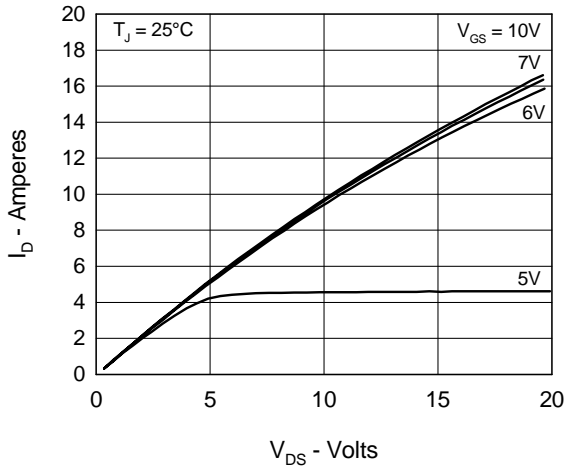


Fig. 2 Input Admittance

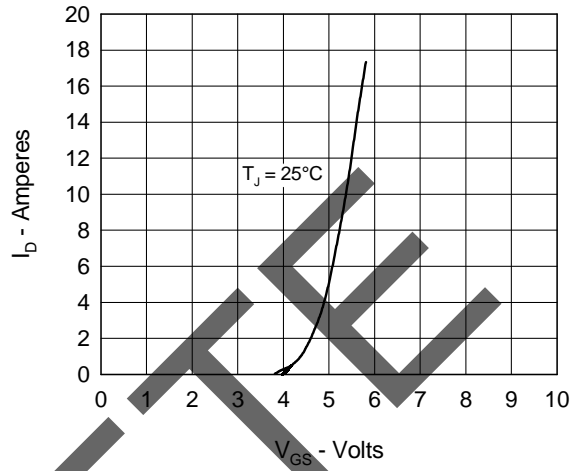


Fig. 3  $R_{DS(on)}$  vs. Drain Current

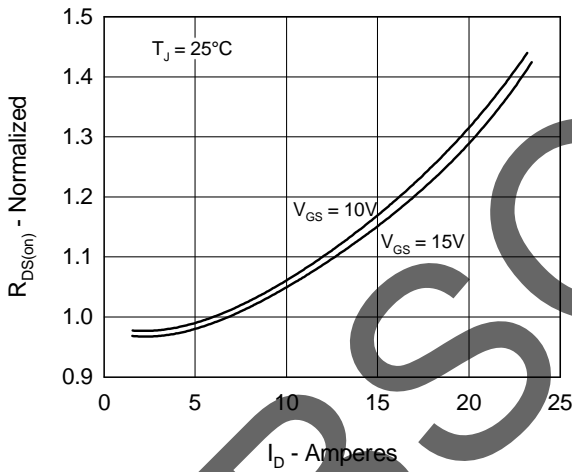


Fig. 4 Temperature Dependence of Drain to Source Resistance

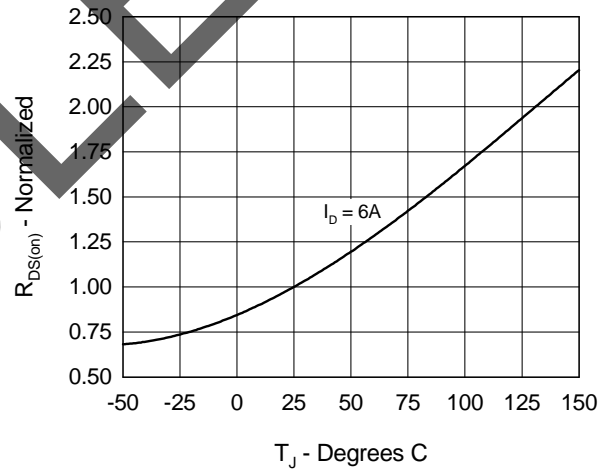


Fig. 5 Drain Current vs. Case Temperature

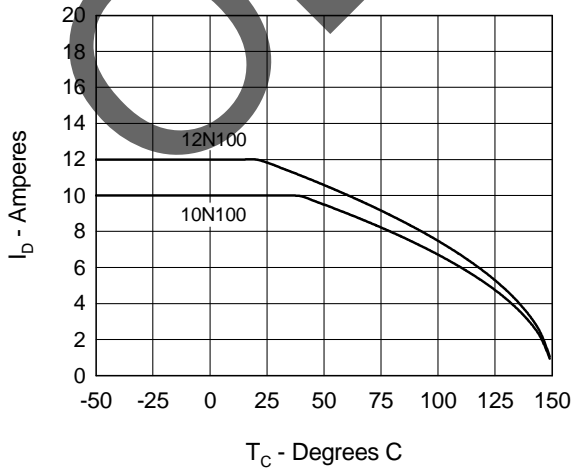


Fig. 6 Temperature Dependence of Breakdown and Threshold Voltage

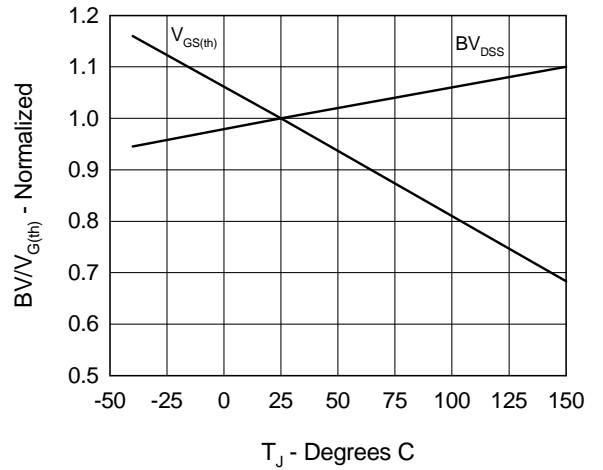


Fig.7 Gate Charge Characteristic Curve

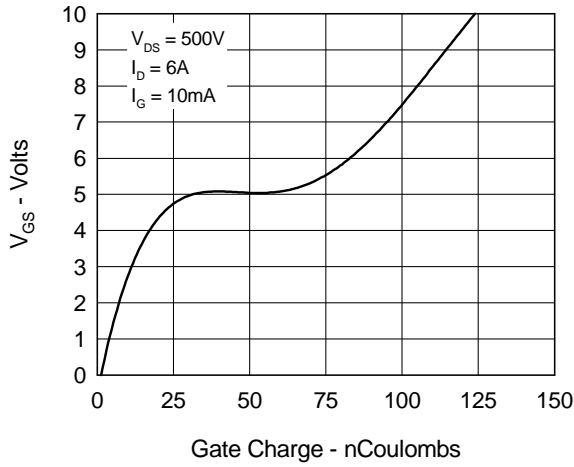


Fig.9 Capacitance Curves

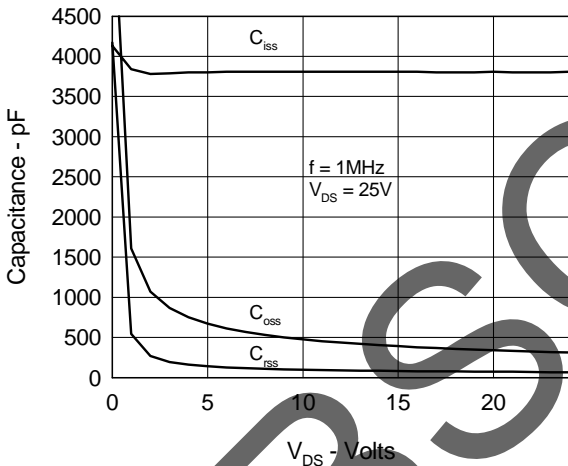


Fig.11 Transient Thermal Impedance

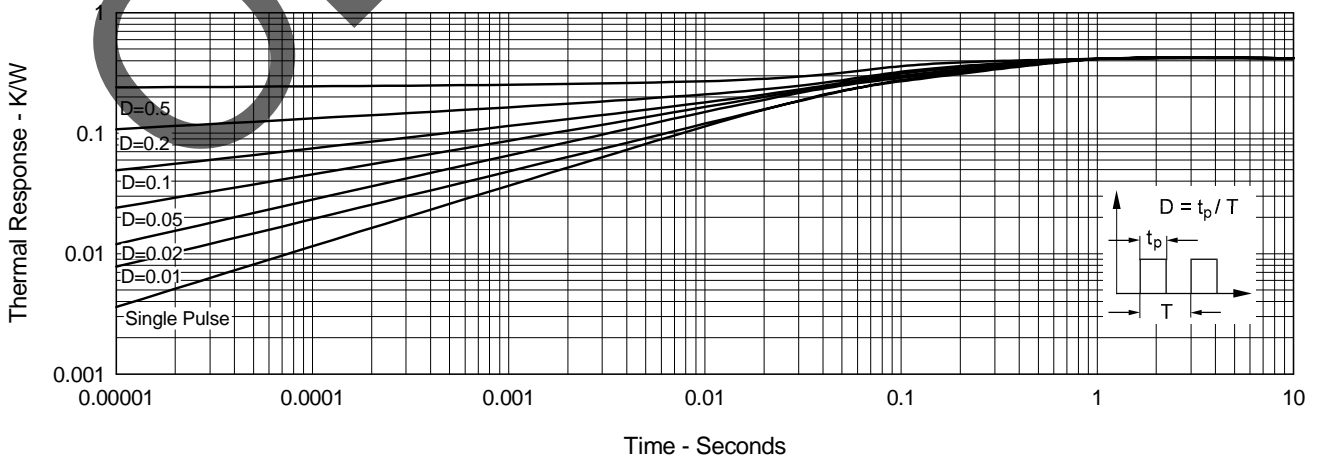


Fig.8 Forward Bias Safe Operating Area

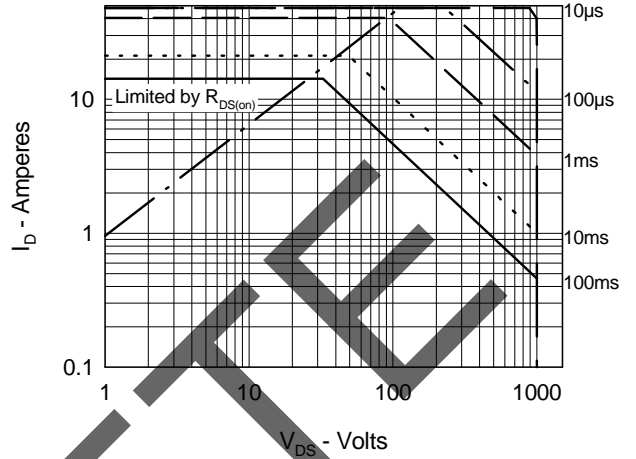


Fig.10 Source Current vs. Source to Drain Voltage

